

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/735,446	YOON ET AL.
	Examiner	Art Unit
	Jared W. Newton	3634

SEARCHED			
Class	Subclass	Date	Examiner
211	183	10/12/05	JWN
16	570		
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	221		
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